Search Notes					

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/615,048	BLATCHFORD, ET AL	•
Examiner	Art Unit	***
Sùn J. Lin	2825	

SEARCHED					
Class	Subclass	Date	Examiner		
716	21	4/7 <i>1</i> 2005	JSL		
716	19	4/7/2005	JSL		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
716	21	4/7/2005	JSL		
716	19	4/7/2005	JSL		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
EAST [USPAT;US- PGPUB;UPO;JPO;DERWENT;IBM_T DB]	4/7 <i>1</i> 2005	JSL		
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